

P-Channel 80 V (D-S) MOSFET

SOT-23 (TO-236) D 3 G Ton View

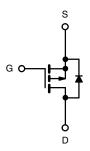
Marking code: E7

PRODUCT SUMMARY						
V _{DS} (V)	-80					
$R_{DS(on)}$ max. (Ω) at $V_{GS} = -10 \text{ V}$	0.270					
$R_{DS(on)}$ max. (Ω) at $V_{GS} = -6 \text{ V}$	0.303					
Q _g typ. (nC)	7					
I _D (A) ^a	-2.2					
Configuration	Single					

FEATURES

- TrenchFET® power MOSFET
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>





P-Channel MOSFET

ORDERING INFORMATION				
Package	SOT-23			
Lead (Pb)-free	Si2337DS-T1-E3			
Lead (Pb)-free and halogen-free	Si2337DS-T1-GE3			

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-source voltage	V _{DS}	-80	V		
Gate-source voltage	V _{GS}	± 20			
	T _C = 25 °C		-2.2		
Continuous dusin surrent (T. 150 °C)	T _C = 70 °C		-1.75		
Continuous drain current (T _J = 150 °C)	T _A = 25 °C	I _D	-1.2 ^{b, c}		
	T _A = 70 °C		-0.96 ^{b, c}	^	
Pulsed drain current	I _{DM}	-7	A		
Continuous source-drain diode current	T _C = 25 °C	,	-2.1		
	T _A = 25 °C	I _S	-0.63 ^{b, c}		
Avalanche current		I _{AS}	11		
Single-pulse avalanche energy	L = 0.1 mH	E _{AS}	6	mJ	
Maximum power dissipation	T _C = 25 °C		2.5		
	T _C = 70 °C		1.6	w	
	T _A = 25 °C	P _D	0.76 b, c	VV	
	T _A = 70 °C		0.48 b, c		
Operating junction and storage temperature rai	T _J , T _{stg}	-55 to +150	**		
Soldering recommendations (peak temperature		260	°C		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient b, d	t ≤ 10 s	R _{thJA}	120	166	°C/W	
Maximum junction-to-foot (drain)	Steady state	R_{thJF}	40	50	C/VV	

Notes

- a. Package limited
- b. Surface mounted on 1" x 1" FR4 board
- c. t = 10 s
- d. Maximum under steady state conditions is 166 °C/W

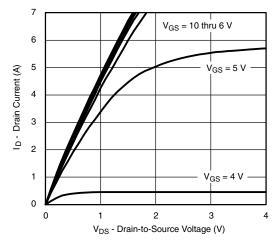
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static					L		
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-80	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$		=.	-35.8	-	m\//06	
V _{GS(th)} temperature coefficient	$\Delta VG_{S(th)}/T_{J}$	I _D = -250 μA	-	5.45	-	mV/°C	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = -250 \mu A$	-2	-	-4	٧	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA	
		$V_{DS} = -80 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	-1	μΑ	
Zero gate voltage drain current	I _{DSS}	V _{DS} = -80 V, V _{GS} = 0 V, T _J = 55 °C	-	-	-10		
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = -10 \text{ V}$	-7	-	-	Α	
	B(OH)	V _{GS} = -10 V, I _D = -1.2 A	_	0.216	0.270	Ω	
Drain-source on-state resistance ^a	R _{DS(on)}	V _{GS} = -6 V, I _D = -1.1 A	_	0.242	0.303		
Forward transconductance ^a	9 _{fs}	$V_{DS} = -15 \text{ V, } I_D = -1.2 \text{ A}$	_	4.3	-	S	
Dynamic b	91S	103 10 1, 10 11=71		1.0			
Input capacitance	C _{iss}		_	500	<u> </u>	pF	
Output capacitance	C _{oss}	$V_{DS} = -40 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	40	_		
Reverse transfer capacitance	C _{rss}	103 101, 103 01, 11111	_	25	_		
Tieverse transfer supusitance	$V_{DS} = -40 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -1.2 \text{ A}$	_	11	17			
Total gate charge	Qg	103 101, 103 101, 10 112,11	_	7	11	nC	
Gate-source charge	Q _{qs}	$V_{DS} = -40 \text{ V}, V_{GS} = -6 \text{ V}, I_D = -1.2 \text{ A}$	_	2.1	_		
Gate-drain charge	Q _{gd}	103 10 1, 103 0 1, 10 11=71	_	3.2	_		
Gate resistance	Ra	f = 1 MHz	-	4.8	-	Ω	
Turn-on delay time	t _{d(on)}		-	10	15		
Rise time	t _r	$V_{DD} = -40 \text{ V}, R_1 = 42 \Omega$	-	15	23		
Turn-off delay time	t _{d(off)}	$I_D \cong -0.96 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$	-	20	30		
Fall time	t _f	-	-	15	23		
Turn-on delay time	t _{d(on)}		-	15	23	ns	
Rise time	t _r	$V_{DD} = -40 \text{ V}, R_{L} = 42 \Omega$	-	18	27	- - -	
Turn-off delay time	t _{d(off)}	$I_D \cong -0.96 \text{ A}, V_{GEN} = -6 \text{ V}, R_g = 1 \Omega$	=.	20	30		
Fall time	t _f		-	12	18		
Drain-Source Body Diode Characteristi	cs			•			
Continuous source-drain diode current	I _S	T _C = 25 °C	-	-	-2.1		
Pulse diode forward current a	I _{SM}		-	-	-7	Α	
Body diode voltage	V _{SD}	I _S = 0.63 A	-	-0.8	-1.2	V	
Body diode reverse recovery time	t _{rr}		-	30	45	ns	
Body diode reverse recovery charge	Q _{rr}	$I_F = 0.63 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	45	70	nC	
Reverse recovery fall time	ta	$T_J = 25 ^{\circ}\text{C}$	-	25	-		
Reverse recovery rise time	t _b		_	5	-	ns	

Notes

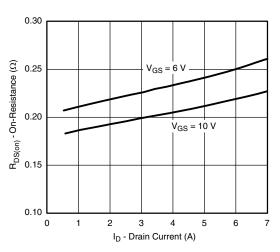
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

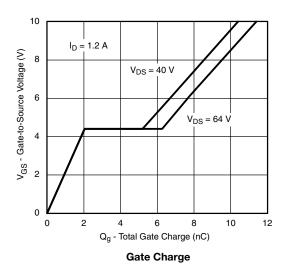


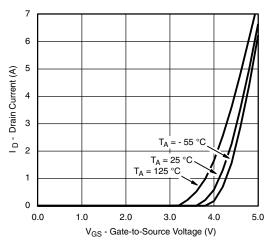


Output Characteristics

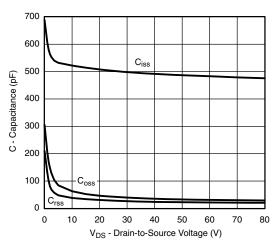


On-Resistance vs. Drain Current and Gate Voltage

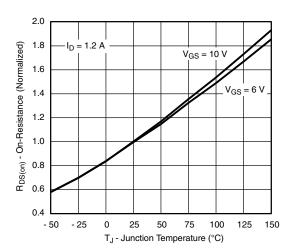




Transfer Characteristics

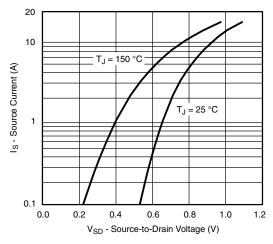


Capacitance

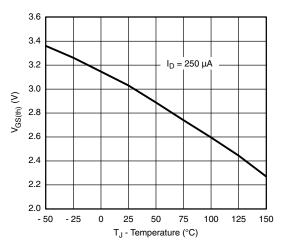


On-Resistance vs. Junction Temperature

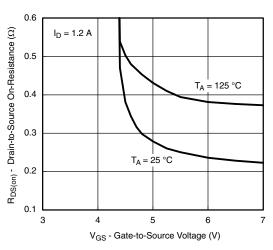




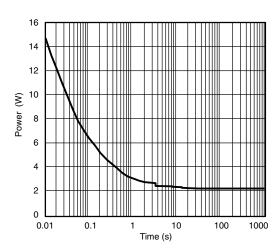
Source-Drain Diode Forward Voltage



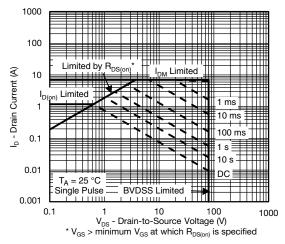
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

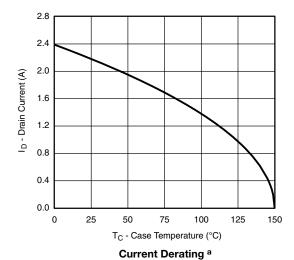


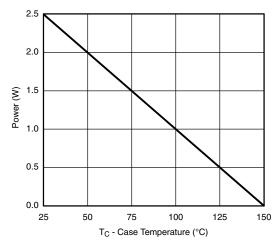
Single Pulse Power, Junction-to-Ambient



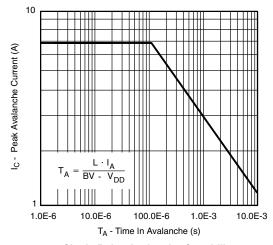
Safe Operating Area, Junction-to-Ambient







Power Derating

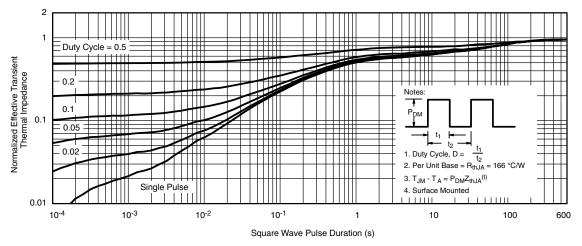


Single Pulse Avalanche Capability

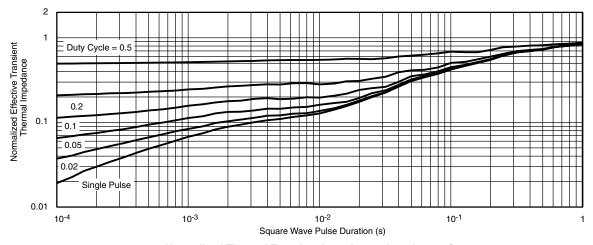
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient

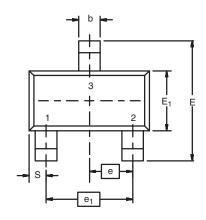


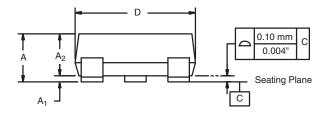
Normalized Thermal Transient Impedance, Junction-to-Case

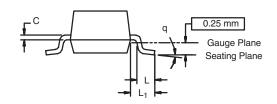
Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package / tape drawings, part marking, and reliability data, see www.vishay.com/ppg?73533.



SOT-23 (TO-236): 3-LEAD







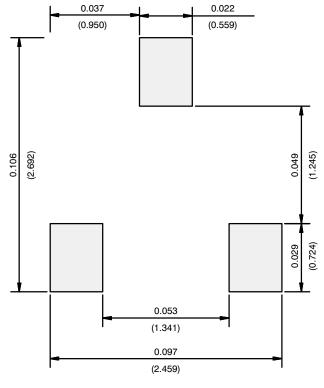
Dim	MILLIN	IETERS	INCHES		
	Min	Max	Min	Max	
Α	0.89	1.12	0.035	0.044	
A ₁	0.01	0.10	0.0004	0.004	
A ₂	0.88	1.02	0.0346	0.040	
b	0.35	0.50	0.014	0.020	
С	0.085	0.18	0.003	0.007	
D	2.80	3.04	0.110	0.120	
E	2.10	2.64	0.083	0.104	
E ₁	1.20	1.40	0.047	0.055	
е	0.95 BSC		0.0374 Ref		
e ₁	1.90 BSC		0.0748 Ref		
L	0.40	0.60	0.016	0.024	
L ₁	0.64 Ref		0.025	i Ref	
S	0.50 Ref		0.020 Ref		
q	3°	8°	3°	8°	
ECN: S-03946-Rev. K. 09-	Jul-01				

DWG: 5479

Document Number: 71196 www.vishay.com 09-Jul-01



RECOMMENDED MINIMUM PADS FOR SOT-23



Recommended Minimum Pads Dimensions in Inches/(mm)

Return to Index

APPLICATION NOTE



Legal Disclaimer Notice

Vishay

Disclaimer

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product.

Vishay makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Vishay disclaims (i) any and all liability arising out of the application or use of any product, (ii) any and all liability, including without limitation special, consequential or incidental damages, and (iii) any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Vishay's knowledge of typical requirements that are often placed on Vishay products in generic applications. Such statements are not binding statements about the suitability of products for a particular application. It is the customer's responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and / or specifications may vary in different applications and performance may vary over time. All operating parameters, including typical parameters, must be validated for each customer application by the customer's technical experts. Product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein.

Except as expressly indicated in writing, Vishay products are not designed for use in medical, life-saving, or life-sustaining applications or for any other application in which the failure of the Vishay product could result in personal injury or death. Customers using or selling Vishay products not expressly indicated for use in such applications do so at their own risk. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay. Product names and markings noted herein may be trademarks of their respective owners.